

D2804, MARCH 1984—REVISED SEPTEMBER 1987

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

These devices contain a single 8-input OR/NOR gate and perform the following Boolean functions in positive logic:

$$W = A + B + C + D + E + F + G + H$$

or

$$W = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D} \cdot \overline{E} \cdot \overline{F} \cdot \overline{G} \cdot \overline{H}$$

and

$$Y = A + B + C + D + E + F + G + H$$

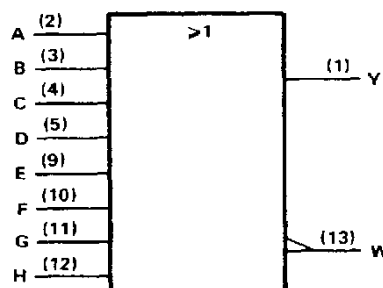
or

$$Y = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D} \cdot \overline{E} \cdot \overline{F} \cdot \overline{G} \cdot \overline{H}$$

The SN54HC4078A is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74HC4078A is characterized for operation from -40°C to 85°C .

FUNCTION TABLE

INPUTS A THRU H	OUTPUTS	
	W	Y
One or more inputs H	L	H
All inputs L	H	L

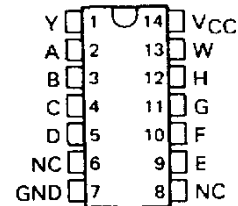
logic symbol†

† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

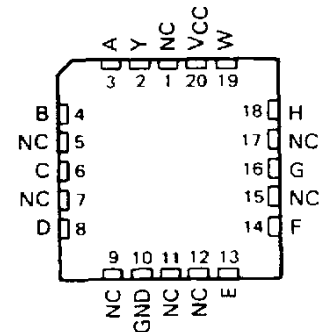
SN54HC4078A . . . J PACKAGE
SN74HC4078A . . . D OR N PACKAGE

(TOP VIEW)

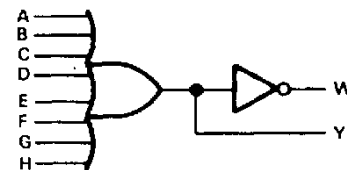


SN54HC4078A . . . FK PACKAGE

(TOP VIEW)



NC—No internal connection

logic diagram (positive logic)

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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SN54HC4078A, SN74HC4078A **8-INPUT OR/NOR GATE**

absolute maximum ratings over operating free-air temperature range†

Supply voltage, V_{CC}	–0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V_{CC} or GND pins	±50 mA
Lead temperature 1,6 mm (1/16 in) from case for 60 s: FK or J package	300°C
Lead temperature 1,6 mm (1/16 in) from case for 10 s: D or N package	260°C
Storage temperature range	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54HC4078A			SN74HC4078A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	2	5	6	2	5	6	V
V_{IH}	High-level input voltage	$V_{CC} = 2\text{ V}$ $V_{CC} = 4.5\text{ V}$ $V_{CC} = 6\text{ V}$			$V_{CC} = 2\text{ V}$ $V_{CC} = 4.5\text{ V}$ $V_{CC} = 6\text{ V}$			V
V_{IL}	Low-level input voltage	$V_{CC} = 2\text{ V}$ $V_{CC} = 4.5\text{ V}$ $V_{CC} = 6\text{ V}$			$V_{CC} = 2\text{ V}$ $V_{CC} = 4.5\text{ V}$ $V_{CC} = 6\text{ V}$			V
V_I	Input voltage	0		V_{CC}	0		V_{CC}	V
V_O	Output voltage	0		V_{CC}	0		V_{CC}	V
t_t	Input transition (rise and fall) times	$V_{CC} = 2\text{ V}$ $V_{CC} = 4.5\text{ V}$ $V_{CC} = 6\text{ V}$			$V_{CC} = 2\text{ V}$ $V_{CC} = 4.5\text{ V}$ $V_{CC} = 6\text{ V}$			ns
T_A	Operating free-air temperature	–55		125	–40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			SN54HC4078A		SN74HC4078A		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
V _{OH}	V _I = V _{IH} or V _{IL} , I _{OH} = -20 μA	2 V	1.9	1.998		1.9		1.9		V	
		4.5 V	4.4	4.499		4.4		4.4			
		6 V	5.9	5.999		5.9		5.9			
	V _I = V _{IH} or V _{IL} , I _{OH} = -4 mA	4.5 V	3.98	4.30		3.7		3.84			
	V _I = V _{IH} or V _{IL} , I _{OH} = -5.2 mA	6 V	5.48	5.80		5.2		5.34			
V _{OL}	V _I = V _{IH} or V _{IL} , I _{OL} = 20 μA	2 V		0.002	0.1		0.1		0.1	V	
		4.5 V		0.001	0.1		0.1		0.1		
		6 V		0.001	0.1		0.1		0.1		
	V _I = V _{IH} or V _{IL} , I _{OL} = 4 mA	4.5 V		0.17	0.26		0.4		0.33		
	V _I = V _{IH} or V _{IL} , I _{OL} = 5.2 mA	6 V		0.15	0.26		0.4		0.33		
I _I	V _I = V _{CC} or 0	6 V		±0.1	±100		±1000		±1000	nA	
I _{CC}	V _I = V _{CC} or 0, I _O = 0	6 V			8		160		80	μA	
C _i		2 to 6 V		3	10		10		10	pF	



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SN54HC4078A, SN74HC4078A
8-INPUT OR/NOR GATE

switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 50$ pF (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC}	$T_A = 25^\circ\text{C}$			SN54HC4078A		SN74HC4078A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	A thru H	Y/W	2 V		40	130		195		165	ns
			4.5 V		12	26		39		33	
			6 V		10	22		33		28	
t_t		Y/W	2 V		38	75		110		95	ns
			4.5 V		8	15		22		19	
			6 V		6	13		19		16	

C_{pd}	Power dissipation capacitance per gate	No load, $T_A = 25^\circ\text{C}$	25 pF typ
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Note 1: Load circuits and voltage waveforms are shown in Section 1.



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